

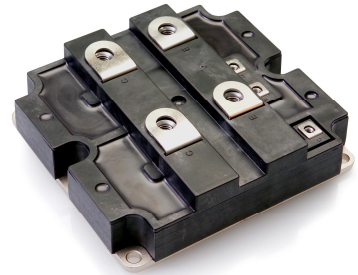
# 5SNA 1000N330300

## ABB HiPak™ IGBT Module

$$V_{CE} = 3300 \text{ V}$$

$$I_C = 1000 \text{ A}$$

Ultra low-loss, rugged SPT<sup>+</sup> chip-set  
 Smooth switching SPT<sup>+</sup> chip-set for good EMC  
 AISiC base-plate for high power cycling capability  
 AlN substrate for low thermal resistance



### Maximum rated values <sup>1)</sup>

| Parameter                      | Symbol       | Conditions  | min | max  | Unit             |
|--------------------------------|--------------|---|-----|------|------------------|
| Collector-emitter voltage      | $V_{CES}$    | $V_{GE} = 0 \text{ V}, T_{vj} \geq 25 \text{ }^\circ\text{C}$   |     | 3300 | V                |
| DC collector current           | $I_C$        | $T_C = 100 \text{ }^\circ\text{C}, T_{vj} = 150 \text{ }^\circ\text{C}$   |     | 1000 | A                |
| Peak collector current         | $I_{CM}$     | $t_p = 1 \text{ ms}$  |     | 2000 | A                |
| Gate-emitter voltage           | $V_{GES}$    |   | -20 | 20   | V                |
| Total power dissipation        | $P_{tot}$    | $T_C = 25 \text{ }^\circ\text{C}, T_{vj} = 150 \text{ }^\circ\text{C}$  |     | 9800 | W                |
| DC forward current             | $I_F$        |   |     | 1000 | A                |
| Peak forward current           | $I_{FRM}$    | $t_p = 1 \text{ ms}$  |     | 2000 | A                |
| Surge current                  | $I_{FSM}$    | $V_R = 0 \text{ V}, T_{vj} = 150 \text{ }^\circ\text{C},$<br>$t_p = 10 \text{ ms}, \text{ half-sinewave}$                                 |     | 9000 | A                |
| IGBT short circuit SOA         | $t_{psc}$    | $V_{CC} = 2500 \text{ V}, V_{CEM \text{ CHIP}} \leq 3300 \text{ V}$<br>$V_{GE} \leq 15 \text{ V}, T_{vj} \leq 150 \text{ }^\circ\text{C}$ |     | 10   | $\mu\text{s}$    |
| Isolation voltage              | $V_{isol}$   | 1 min, $f = 50 \text{ Hz}$  |     | 6000 | V                |
| Junction temperature           | $T_{vj}$     |   | -40 | 150  | $^\circ\text{C}$ |
| Junction operating temperature | $T_{vj(op)}$ |   | -40 | 150  | $^\circ\text{C}$ |
| Case temperature               | $T_C$        |   | -40 | 125  | $^\circ\text{C}$ |
| Storage temperature            | $T_{stg}$    |   | -40 | 125  | $^\circ\text{C}$ |
| Mounting torques <sup>2)</sup> | $M_s$        | Base- heatsink, M6 screws   | 4   | 6    | Nm               |
|                                | $M_{t1}$     | Main terminals, M8 screws   | 8   | 10   |                  |
|                                | $M_{t2}$     | Auxiliary terminals, M4 screws  | 2   | 3    |                  |

<sup>1)</sup> Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747

<sup>2)</sup> for detailed mounting instructions refer to ABB Document No. 5SYA2039

**IGBT characteristic values <sup>3)</sup>**

| Parameter  | Symbol               | Conditions   | min                                   | typ  | max  | Unit          |
|--|----------------------|--|---------------------------------------|------|------|---------------|
| Collector (-emitter) breakdown voltage             | $V_{(BR)CES}$        | $V_{GE} = 0 \text{ V}$ , $I_C = 10 \text{ mA}$ , $T_{vj} = 25 \text{ }^\circ\text{C}$  | 3300                                  |      |      | V             |
| Collector-emitter <sup>4)</sup> saturation voltage | $V_{CE \text{ sat}}$ | $I_C = 1000 \text{ A}$ , $V_{GE} = 15 \text{ V}$   | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 2.5  | 2.9  | V             |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 3.1  | 3.4  | V             |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 3.25 |      | V             |
| Collector cut-off current                          | $I_{CES}$            | $V_{CE} = 3300 \text{ V}$ , $V_{GE} = 0 \text{ V}$   | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 0.04 | 0.67 | mA            |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 13.5 | 27   | mA            |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 67   |      | mA            |
| Gate leakage current                               | $I_{GES}$            | $V_{CE} = 0 \text{ V}$ , $V_{GE} = \pm 20 \text{ V}$ , $T_{vj} = 125 \text{ }^\circ\text{C}$   | -500                                  |      | 500  | nA            |
| Gate-emitter threshold voltage                     | $V_{GE(TO)}$         | $I_C = 160 \text{ mA}$ , $V_{CE} = V_{GE}$ , $T_{vj} = 25 \text{ }^\circ\text{C}$  | 5                                     |      | 7    | V             |
| Gate charge  | $Q_{ge}$             | $I_C = 1000 \text{ A}$ , $V_{CE} = 1800 \text{ V}$ , $V_{GE} = -15 \text{ V} \dots 15 \text{ V}$   |                                       | 7.33 |      | $\mu\text{C}$ |
| Input capacitance                                  | $C_{ies}$            | $V_{CE} = 25 \text{ V}$ , $V_{GE} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ ,<br>$T_{vj} = 25 \text{ }^\circ\text{C}$   |                                       | 101  |      | nF            |
| Output capacitance                                 | $C_{oes}$            |  |                                       | 8.4  |      | nF            |
| Reverse transfer capacitance                       | $C_{res}$            |  |                                       | 2.57 |      | nF            |
| Turn-on delay time                                 | $t_{d(on)}$          | $V_{CC} = 1800 \text{ V}$ , $I_C = 1000 \text{ A}$ ,<br>$R_G = 1.5 \text{ } \Omega$ , $C_{GE} = 220 \text{ nF}$ ,<br>$V_{GE} = \pm 15 \text{ V}$ ,<br>$L_\sigma = 100 \text{ nH}$ , inductive load | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 560  |      | ns            |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 530  |      | ns            |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 530  |      | ns            |
| Rise time  | $t_r$                | $V_{CC} = 1800 \text{ V}$ , $I_C = 1000 \text{ A}$ ,<br>$R_G = 1.5 \text{ } \Omega$ , $C_{GE} = 220 \text{ nF}$ ,<br>$V_{GE} = \pm 15 \text{ V}$ ,<br>$L_\sigma = 100 \text{ nH}$ , inductive load | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 240  |      | ns            |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 255  |      | ns            |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 260  |      | ns            |
| Turn-off delay time                                | $t_{d(off)}$         | $V_{CC} = 1800 \text{ V}$ , $I_C = 1000 \text{ A}$ ,<br>$R_G = 2.2 \text{ } \Omega$ , $C_{GE} = 220 \text{ nF}$ ,<br>$V_{GE} = \pm 15 \text{ V}$ ,<br>$L_\sigma = 100 \text{ nH}$ , inductive load | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 1465 |      | ns            |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 1640 |      | ns            |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 1700 |      | ns            |
| Fall time  | $t_f$                | $V_{CC} = 1800 \text{ V}$ , $I_C = 1000 \text{ A}$ ,<br>$R_G = 2.2 \text{ } \Omega$ , $C_{GE} = 220 \text{ nF}$ ,<br>$V_{GE} = \pm 15 \text{ V}$ ,<br>$L_\sigma = 100 \text{ nH}$ , inductive load | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 315  |      | ns            |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 385  |      | ns            |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 400  |      | ns            |
| Turn-on switching energy                           | $E_{on}$             | $V_{CC} = 1800 \text{ V}$ , $I_C = 1000 \text{ A}$ ,<br>$R_G = 1.5 \text{ } \Omega$ , $C_{GE} = 220 \text{ nF}$ ,<br>$V_{GE} = \pm 15 \text{ V}$ ,<br>$L_\sigma = 100 \text{ nH}$ , inductive load | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 1250 |      | mJ            |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 1640 |      | mJ            |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 1800 |      | mJ            |
| Turn-off switching energy                          | $E_{off}$            | $V_{CC} = 1800 \text{ V}$ , $I_C = 1000 \text{ A}$ ,<br>$R_G = 2.2 \text{ } \Omega$ , $C_{GE} = 220 \text{ nF}$ ,<br>$V_{GE} = \pm 15 \text{ V}$ ,<br>$L_\sigma = 100 \text{ nH}$ , inductive load | $T_{vj} = 25 \text{ }^\circ\text{C}$  | 1240 |      | mJ            |
|  |                      |  | $T_{vj} = 125 \text{ }^\circ\text{C}$ | 1730 |      | mJ            |
|  |                      |  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 1870 |      | mJ            |
| Short circuit current                              | $I_{SC}$             | $t_{psc} \leq 10 \text{ } \mu\text{s}$ , $V_{GE} = 15 \text{ V}$ ,<br>$V_{CC} = 2500 \text{ V}$ ,<br>$V_{CEM \text{ CHIP}} \leq 3300 \text{ V}$  | $T_{vj} = 150 \text{ }^\circ\text{C}$ | 4270 |      | A             |

<sup>3)</sup> Characteristic values according to IEC 60747 - 9

<sup>4)</sup> Collector-emitter saturation voltage is given at chip level

## Diode characteristic values <sup>5)</sup>

| Parameter                     | Symbol    | Conditions   | min                       | typ  | max | Unit    |
|-------------------------------|-----------|--|---------------------------|------|-----|---------|
| Forward voltage <sup>6)</sup> | $V_F$     | $I_F = 1000 \text{ A}$   | $T_{vj} = 25 \text{ °C}$  | 2.05 | 2.5 | V       |
|                               |           |  | $T_{vj} = 125 \text{ °C}$ | 2.25 | 2.6 | V       |
|                               |           |  | $T_{vj} = 150 \text{ °C}$ | 2.20 |     | V       |
| Reverse recovery current      | $I_{rr}$  |  | $T_{vj} = 25 \text{ °C}$  | 1010 |     | A       |
|                               |           |  | $T_{vj} = 125 \text{ °C}$ | 1180 |     | A       |
|                               |           |  | $T_{vj} = 150 \text{ °C}$ | 1230 |     | A       |
| Recovered charge              | $Q_{rr}$  | $V_{CC} = 1800 \text{ V}$ ,<br>$I_F = 1000 \text{ A}$ ,<br>$V_{GE} = \pm 15 \text{ V}$ ,<br>$R_G = 1.5 \text{ }\Omega$ , $C_{GE} = 220 \text{ nF}$ ,<br>$di/dt = 4 \text{ kA/us}$ $kA/\mu s$<br>$L_\sigma = 100 \text{ nH}$ , inductive load | $T_{vj} = 25 \text{ °C}$  | 630  |     | $\mu C$ |
|                               |           |  | $T_{vj} = 125 \text{ °C}$ | 1020 |     | $\mu C$ |
|                               |           |  | $T_{vj} = 150 \text{ °C}$ | 1180 |     | $\mu C$ |
| Reverse recovery time         | $t_{rr}$  |  | $T_{vj} = 25 \text{ °C}$  | 1125 |     | ns      |
|                               |           |  | $T_{vj} = 125 \text{ °C}$ | 1440 |     | ns      |
|                               |           |  | $T_{vj} = 150 \text{ °C}$ | 1630 |     | ns      |
| Reverse recovery energy       | $E_{rec}$ |  | $T_{vj} = 25 \text{ °C}$  | 700  |     | mJ      |
|                               |           |  | $T_{vj} = 125 \text{ °C}$ | 1210 |     | mJ      |
|                               |           |  | $T_{vj} = 150 \text{ °C}$ | 1420 |     | mJ      |

<sup>5)</sup> Characteristic values according to IEC 60747 - 2

<sup>6)</sup> Forward voltage is given at chip level

## Package properties <sup>7)</sup>

| Parameter   | Symbol             | Conditions                                    | min                    | typ   | max   | Unit       |
|---|--------------------|---|------------------------|-------|-------|------------|
| IGBT thermal resistance junction to case                | $R_{th(j-c)IGBT}$  |   |                        |       | 0.013 | K/W        |
| Diode thermal resistance junction to case               | $R_{th(j-c)DIODE}$ |   |                        |       | 0.025 | K/W        |
| IGBT thermal resistance <sup>2)</sup> case to heatsink  | $R_{th(c-s)IGBT}$  | IGBT per switch, $\lambda$ grease = 1W/m x K  |                        | 0.012 |       | K/W        |
| Diode thermal resistance <sup>2)</sup> case to heatsink | $R_{th(c-s)DIODE}$ | Diode per switch, $\lambda$ grease = 1W/m x K |                        | 0.024 |       | K/W        |
| Comparative tracking index                              | CTI                |   |                        | > 600 |       |            |
| Module stray inductance                                 | $L_{\sigma CE}$    |   |                        | 12    |       | nH         |
| Resistance, terminal-chip                               | $R_{CC'+EE'}$      |   | $T_C = 25 \text{ °C}$  | 0.083 |       | m $\Omega$ |
|   |                    |   | $T_C = 125 \text{ °C}$ | 0.113 |       |            |
|   |                    |   | $T_C = 150 \text{ °C}$ | 0.120 |       |            |

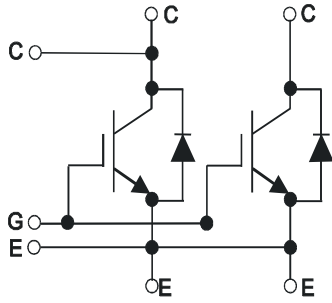
<sup>2)</sup> for detailed mounting instructions refer to ABB Document No. 5SYA2039

## Mechanical properties <sup>7)</sup>

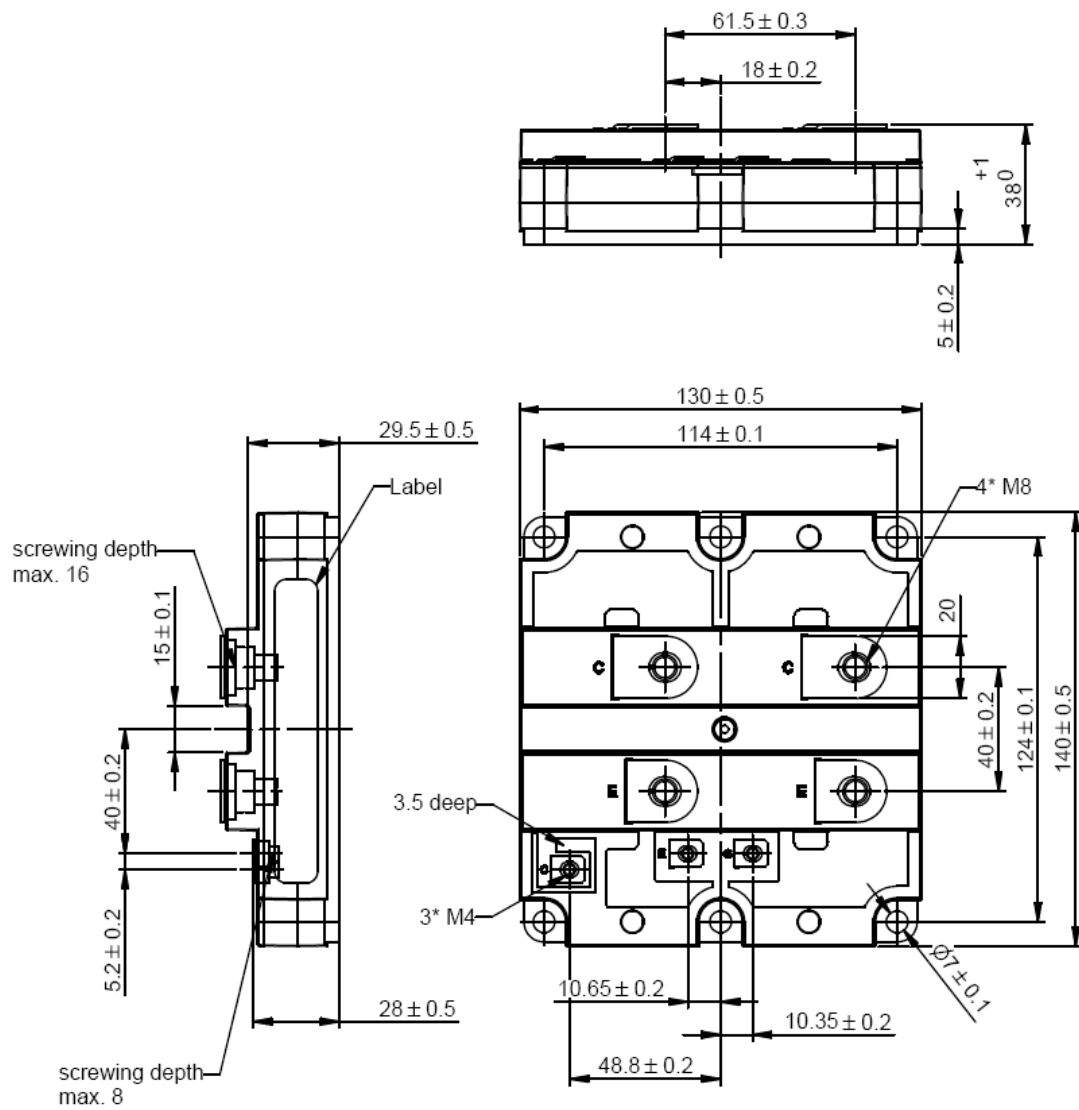
| Parameter                 | Symbol    | Conditions                              | min            | typ            | max | Unit |
|---------------------------|-----------|---|----------------|----------------|-----|------|
| Dimensions                | L x W x H | Typical                                 |                | 130 x 140 x 38 |     | mm   |
| Clearance distance in air | $d_a$     | according to IEC 60664-1 and EN 50124-1 | Term. to base: | 19             |     | mm   |
|                           |           |   | Term. to term: | 19             |     |      |
| Surface creepage distance | $d_s$     | according to IEC 60664-1 and EN 50124-1 | Term. to base: | 32             |     | mm   |
|                           |           |   | Term. to term: | 32             |     |      |
| Mass                      | m         |   |                | 920            |     | g    |

<sup>7)</sup> Package and mechanical properties according to IEC 60747 - 15

## Electrical configuration



## Outline drawing <sup>2)</sup>



Note: all dimensions are shown in millimeters

<sup>2)</sup> For detailed mounting instructions refer to ABB Document No. 5SYA2039

This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. IX.  
This product has been designed and qualified for Industrial Level.

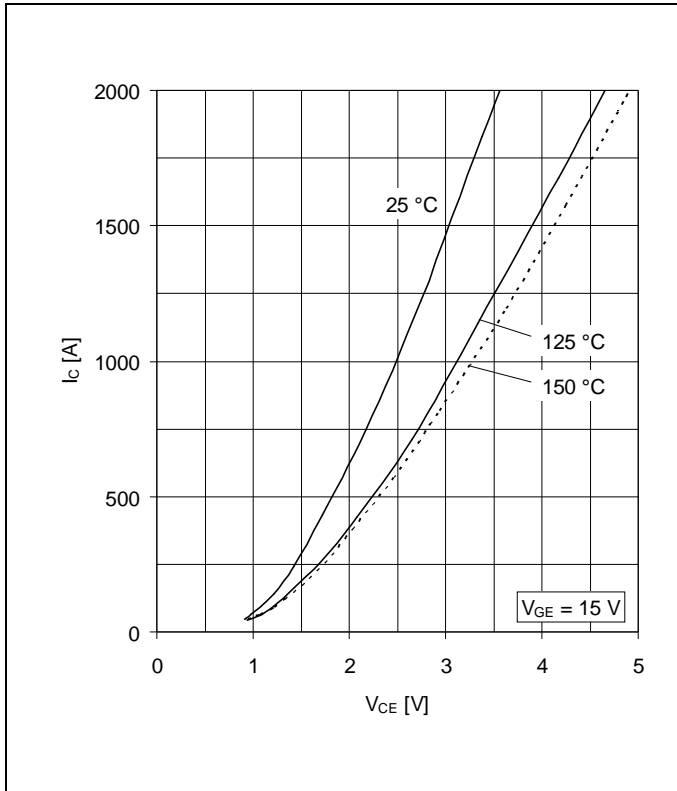


Fig. 1 Typical on-state characteristics, chip level

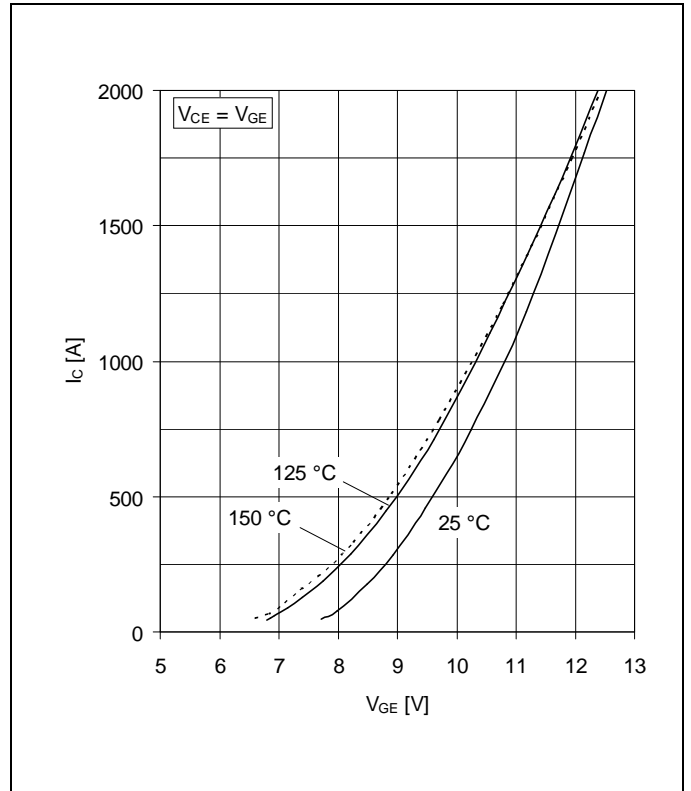


Fig. 2 Typical transfer characteristics, chip level

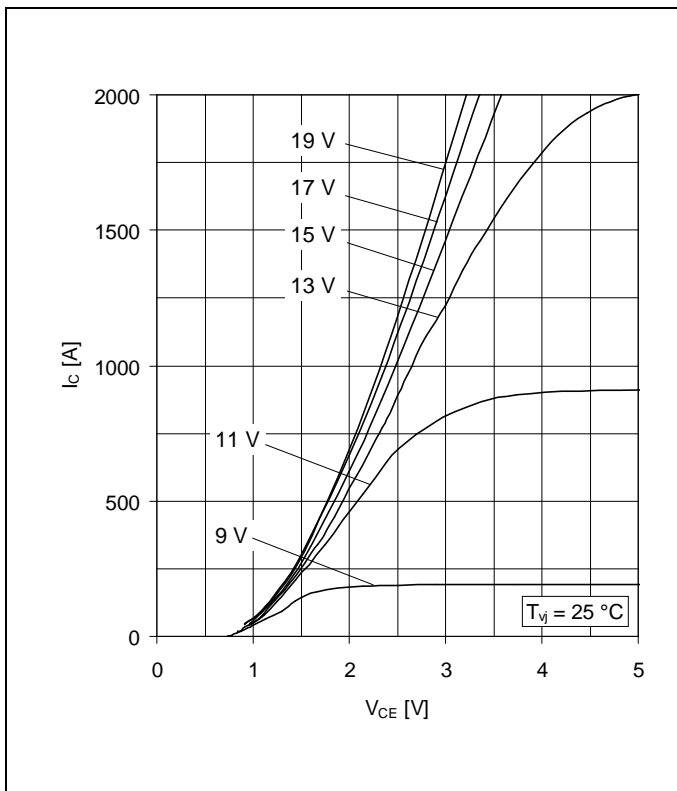


Fig. 3 Typical output characteristics, chip level

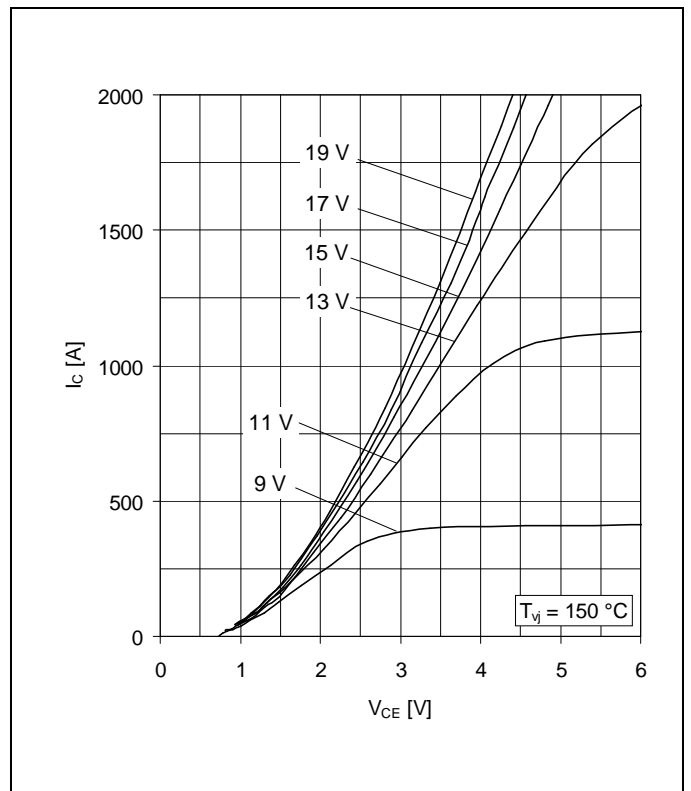


Fig. 4 Typical output characteristics, chip level

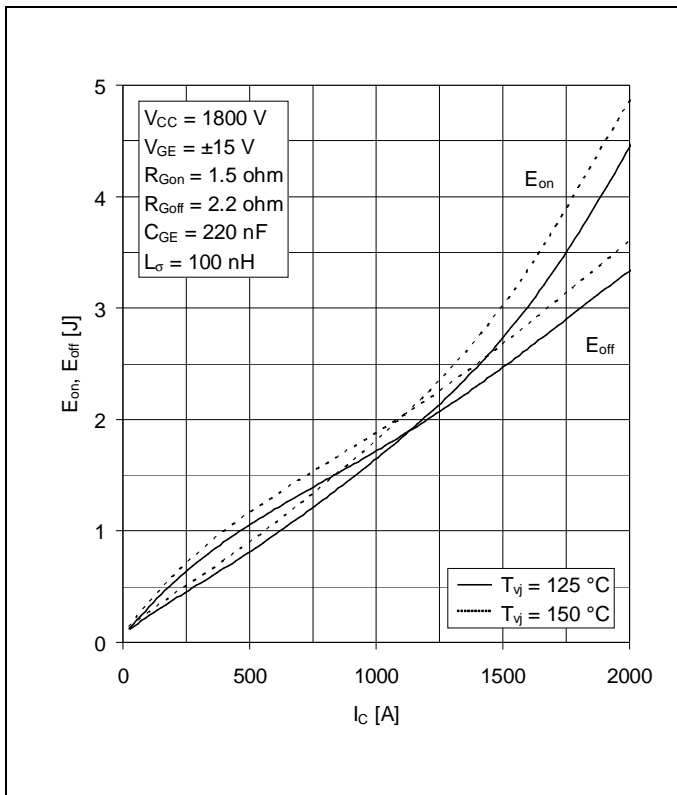


Fig. 5 Typical switching energies per pulse vs collector current

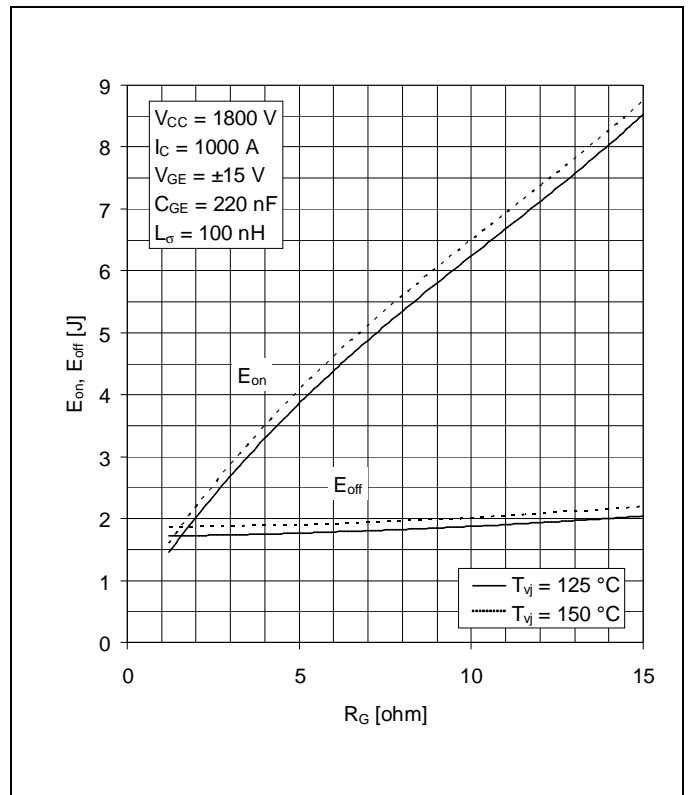


Fig. 6 Typical switching energies per pulse vs gate resistor

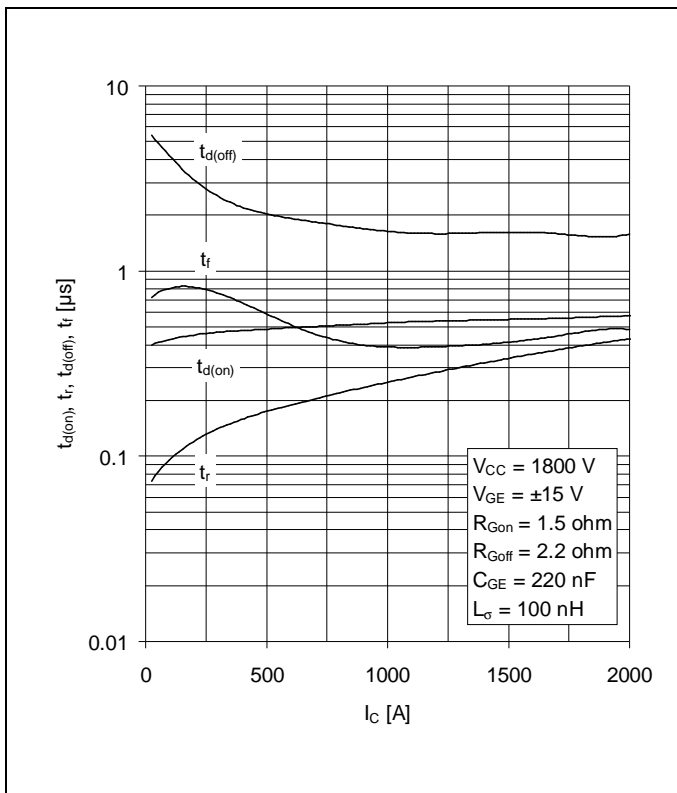


Fig. 7 Typical switching times vs collector current

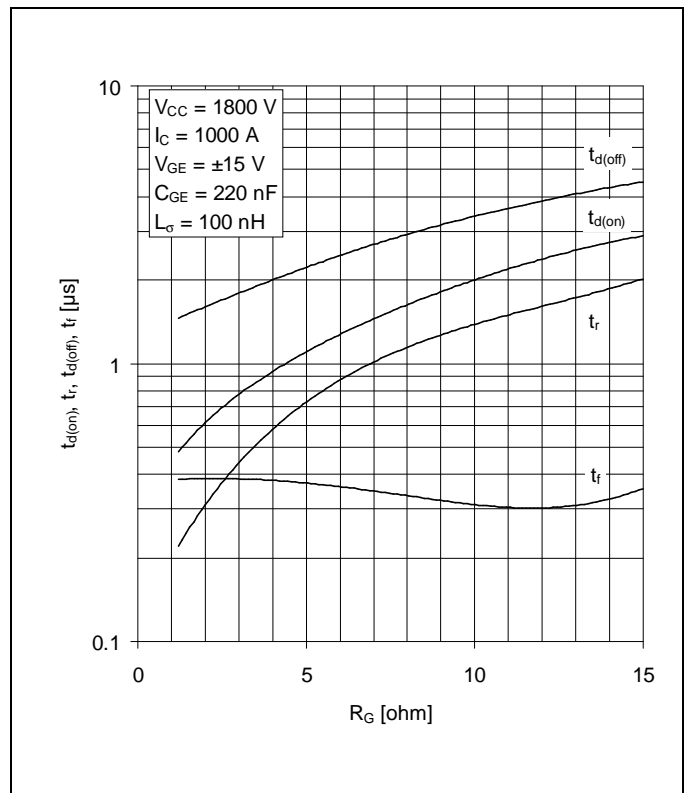


Fig. 8 Typical switching times vs gate resistor

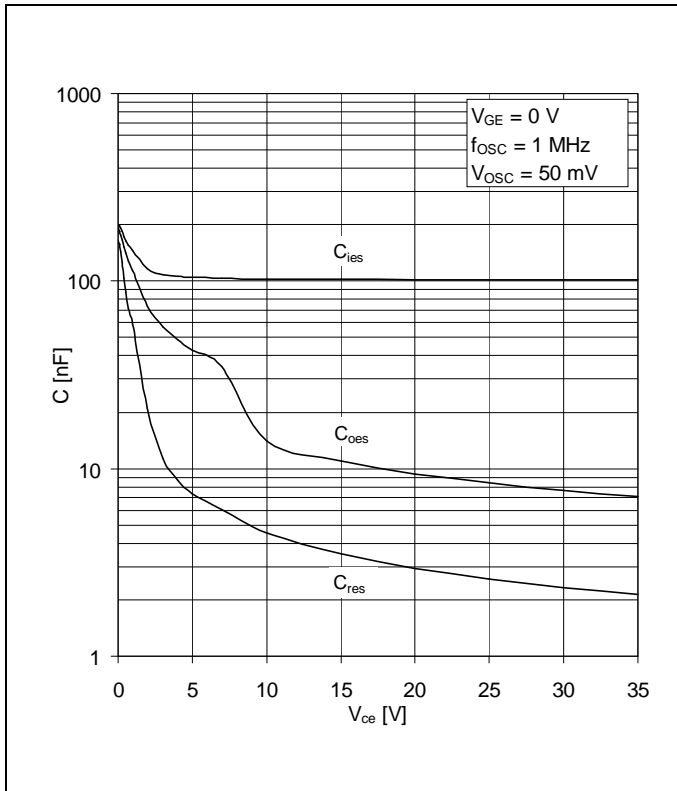


Fig. 9 Typical capacitances vs collector-emitter voltage

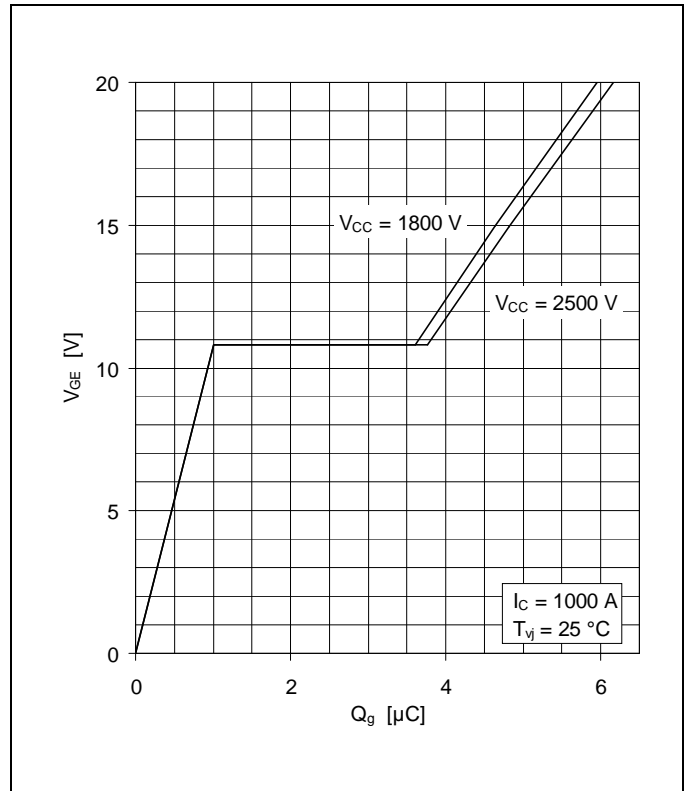


Fig. 10 Typical gate charge characteristics

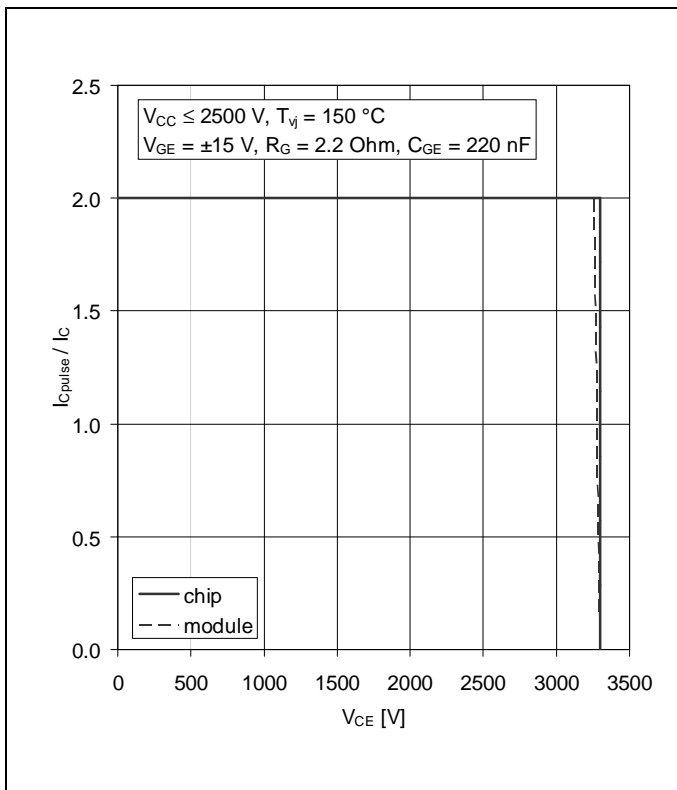


Fig. 11 Turn-off safe operating area (RBSOA)

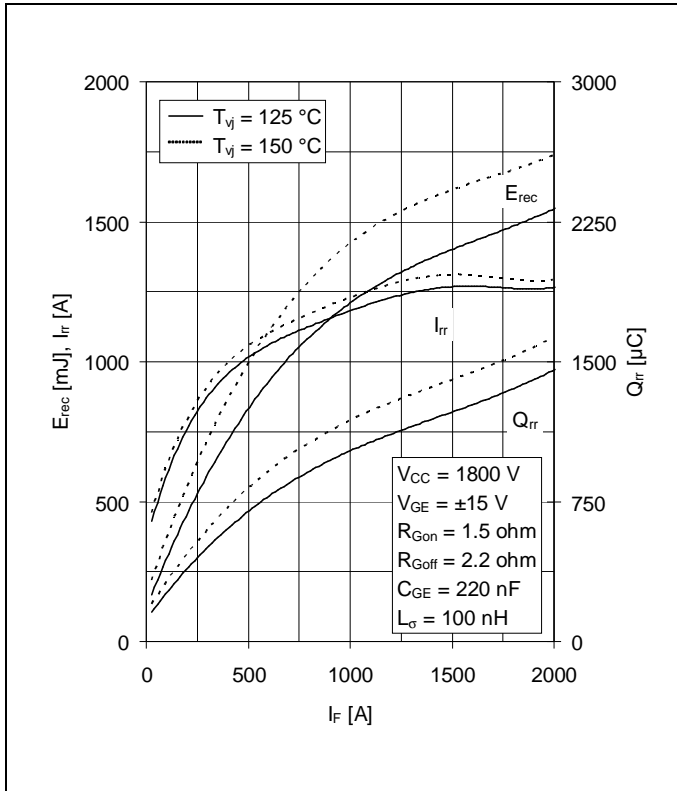


Fig. 12 Typical reverse recovery characteristics vs forward current

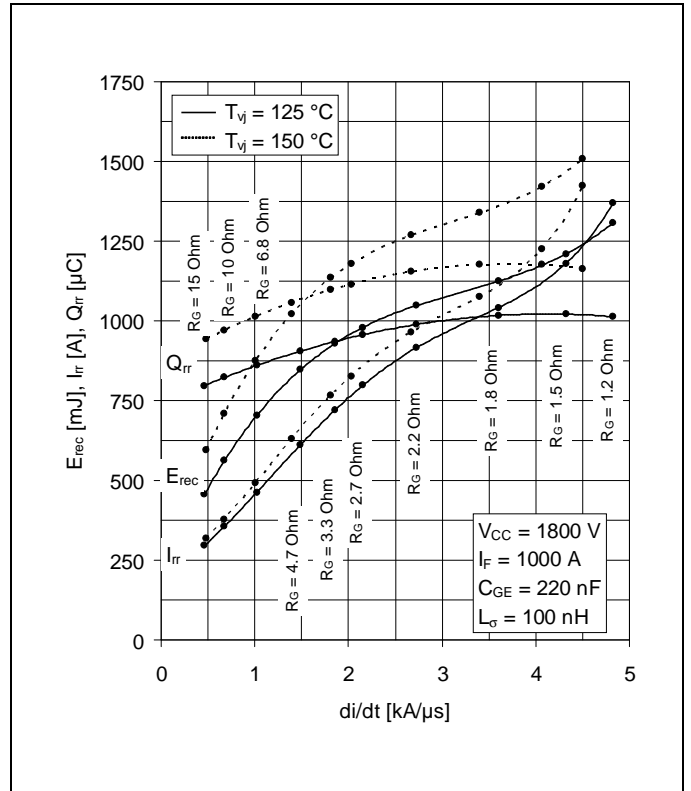


Fig. 13 Typical reverse recovery characteristics vs  $di/dt$

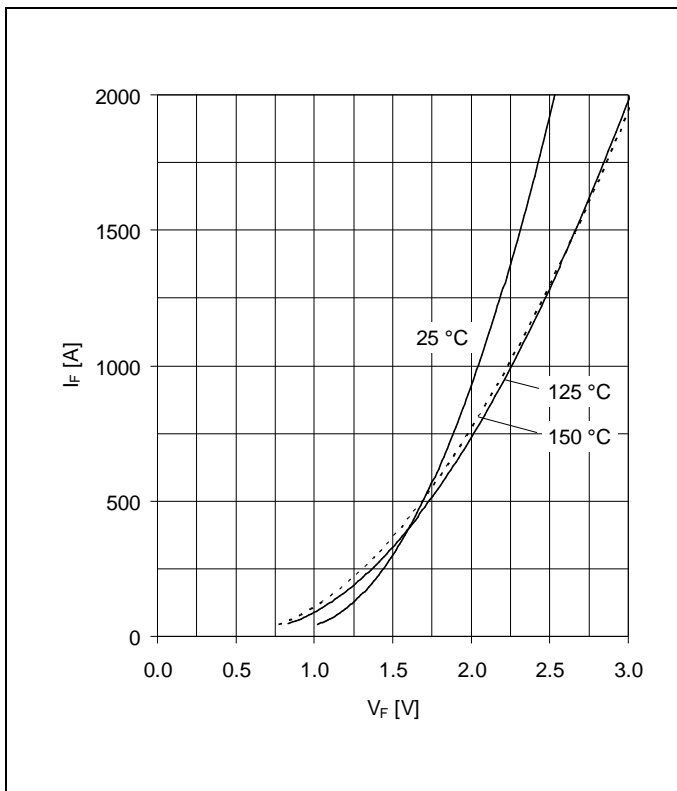


Fig. 14 Typical diode forward characteristics chip level

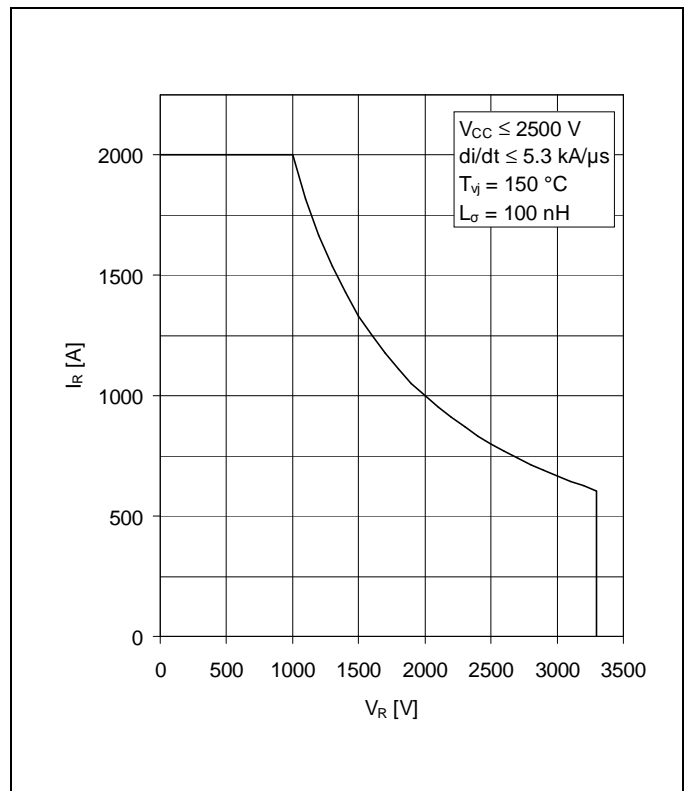


Fig. 15 Safe operating area diode (SOA)



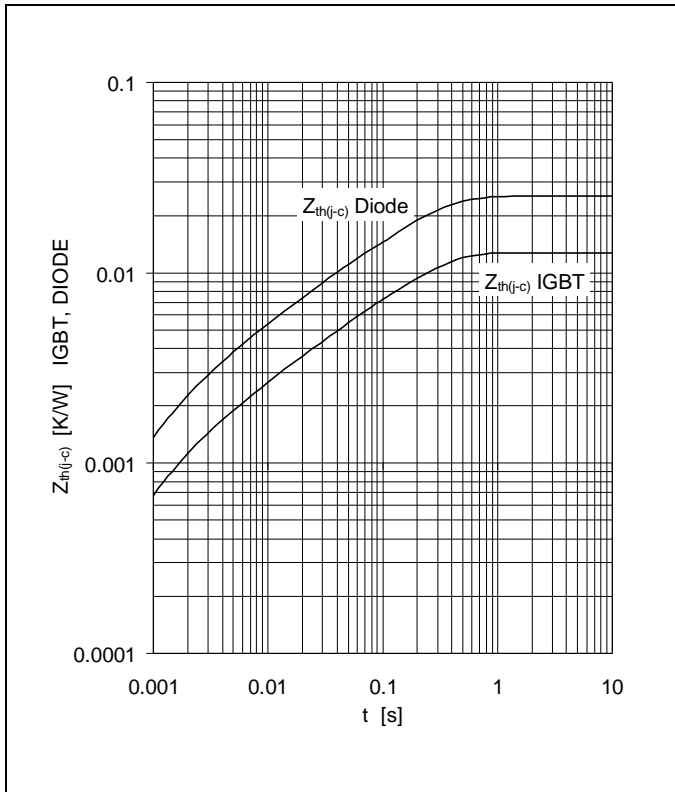


Fig. 16 Thermal impedance vs time

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/t_i})$$

|       |          |       |      |       |       |   |
|-------|----------|-------|------|-------|-------|---|
|       | i        | 1     | 2    | 3     | 4     | 5 |
| IGBT  | Ri(K/kW) | 8.78  | 2.06 | 0.961 | 0.948 |   |
|       | τi(ms)   | 207.4 | 30.1 | 7.55  | 1.57  |   |
| DIODE | Ri(K/kW) | 17.1  | 4.28 | 1.92  | 1.92  |   |
|       | τi(ms)   | 203.6 | 30.1 | 7.53  | 1.57  |   |

#### Related documents:

- 5SYA 2042 Failure rates of HiPak modules due to cosmic rays
- 5SYA 2043 Load - cycle capability of HiPaks
- 5SYA 2045 Thermal runaway during blocking
- 5SYA 2053 Applying IGBT
- 5SYA 2058 Surge currents for IGBT diodes
- 5SZK 9111 Specification of environmental class for HiPak Storage
- 5SZK 9112 Specification of environmental class for HiPak Transportation
- 5SZK 9113 Specification of environmental class for HiPak Operation (Industry)
- 5SZK 9120 Specification of environmental class for HiPak

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